

Notice of References Cited	Application/Control No. 10/028,309		Applicant(s)/Patent Under Reexamination HOLLIDAY ET AL.	
	Examiner Tan Dean D. Nguyen		Art Unit 3689	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0032574	03-2002	Lowrance et al.	705/1
*	B	US-2003/0097319	05-2003	Moldovan et al.	705/35
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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